

## Basics of N-Channel MOSFET Gate Driver ICs (TCK401G and TCK402G)

### Outline:

This Gate Driver IC drives the gate of N-channel MOSFET used for the load switch. A proper high voltage must be applied to the gate to turn MOSFET on with low on-resistance. In addition to the charge pump circuitry that drives the N-channel MOSFET, the built-in overvoltage protection, under voltage malfunction prevention (UVLO), slew rate control, auto-discharge, and back-to-back protection provide a robust power management system.

This document explains the functions and precautions for use using TCK401G/ TCK402G as an example that is ultra-compact and achieves higher operating voltages.

## Table of Contents

Outline: .....	1
Table of Contents .....	2
1. Introduction.....	4
1.1. Applications of the TCK401G and TCK402G.....	4
2. Difference between the TCK401G and TCK402G.....	5
3. Internal block diagram and operations of the TCK401G and TCK402G .....	6
4. Protection features .....	10
4.1. Reverse-current blocking using external common-source MOSFETs .....	10
4.2. Undervoltage lockout (UVLO).....	11
4.3. Overvoltage lockout (OVLO) .....	12
4.4. Input-tolerant function.....	12
5. Switching times of the TCK401G and TCK402G .....	13
5.1. Switching times of the $V_{GATE}$ terminal .....	13
6. Usage Considerations.....	14
6.1. Input and output capacitors.....	14
6.2. $V_{CT}$ terminal .....	14
6.3. $V_{SRC}$ terminal .....	15
6.4. DIS terminal.....	15
7. Conclusion.....	15
8. Related Links .....	16
9. RESTRICTIONS ON PRODUCT USE.....	17

## List of Figures

Figure 1.1 Application example for the TCK401G and TCK402G .....	4
Figure 2.1 Operation of the TCK401G (active-High).....	5
Figure 2.2 Operation of the TCK402G (active-Low) .....	5
Figure 3.1 Internal block diagram of the TCK401G and TCK402G .....	6
Figure 3.2 $V_{GATE} - V_{IN}$ curve of the TCK401G and TCK402G .....	7
Figure 3.3 Output waveforms of a load switch composed of discrete MOSFETs .....	8
Figure 3.4 Output waveform of a load switch configured using the TCK401G.....	8
Figure 3.5 $V_{GATE}$ ON time - Gate capacitance.....	9
Figure 3.6 Automatic output discharge circuit of the TCK401G and TCK402G .....	10
Figure 3.7 Output waveform of the TCK401G when the automatic output discharge function is disabled. 10	
Figure 3.8 Output waveform of the TCK401G when the automatic output discharge function is enabled . 10	
Figure 4.1 Reverse-current blocking using back-to-back MOSFETs .....	11
Figure 4.2 Undervoltage lockout (UVLO) operation.....	11
Figure 4.3 Overvoltage lockout (OVLO) operation.....	12
Figure 4.4 Input-tolerant function .....	12
Figure 5.1 Switching times of the TCK401G .....	13
Figure 5.2 Switching times of the TCK402G .....	13
Figure 6.1 Applications circuit for the TCK401G and TCK402G.....	14
Figure 6.2 Operations of typical and Schmitt trigger inverters.....	14

## List of Tables

Table 2.1 Difference between the TCK401G and TCK402G.....	5
Table 3.1 Gate drive voltage characteristics of the TCK401G and TCK402G.....	7
Table 3.2 Output current (gate drive current) characteristic of the TCK401G and TCK402G.....	7
Table 3.3 $V_{GATE}$ ON time ( $t_{ON}$ ) simulation data.....	9

## 1. Introduction

The TCK401G and TCK402G are MOSFET gate driver ICs that make it possible to supply high current and voltage to a load using external N-channel MOSFETs. The TCK401G and TCK402G provide reverse-current blocking when two MOSFETs are externally connected in a common-source configuration.

Having a sufficient capability to drive low-on-resistance N-channel MOSFETs, the TCK401G and TCK402G allow a circuit configuration with minimum power dissipation and heat generation. The USB PD Specification requires not only an increase in current to reduce the charging time but also a tolerance for high charging voltage. The TCK401G and TCK402G operate over a wide input voltage range from 2.7 V to 28 V and therefore support USB PD and other rapid-charging loads. These MOSFET gate driver ICs incorporate a slew rate control function to limit unexpected inrush current during switch-on in order to protect the subsequent IC or circuitry. The TCK401G and TCK402G also provide automatic output discharge at switch-off. Therefore, they can be used for applications requiring stringent power management without any concern about a lag between a switch-off signal and the time when the output voltage reaches zero.

This application note discusses the operations and features of the TCK401G and TCK402G, N-channel MOSFET gate driver ICs designed for high-current power management to reduce system power consumption and improve system stability.

### 1.1. Applications of the TCK401G and TCK402G

The TCK401G and TCK402G are optimum for the following applications(Figure 1.1):

- Battery charging and other power management applications
- Charging/discharging circuits for devices with a USB connector

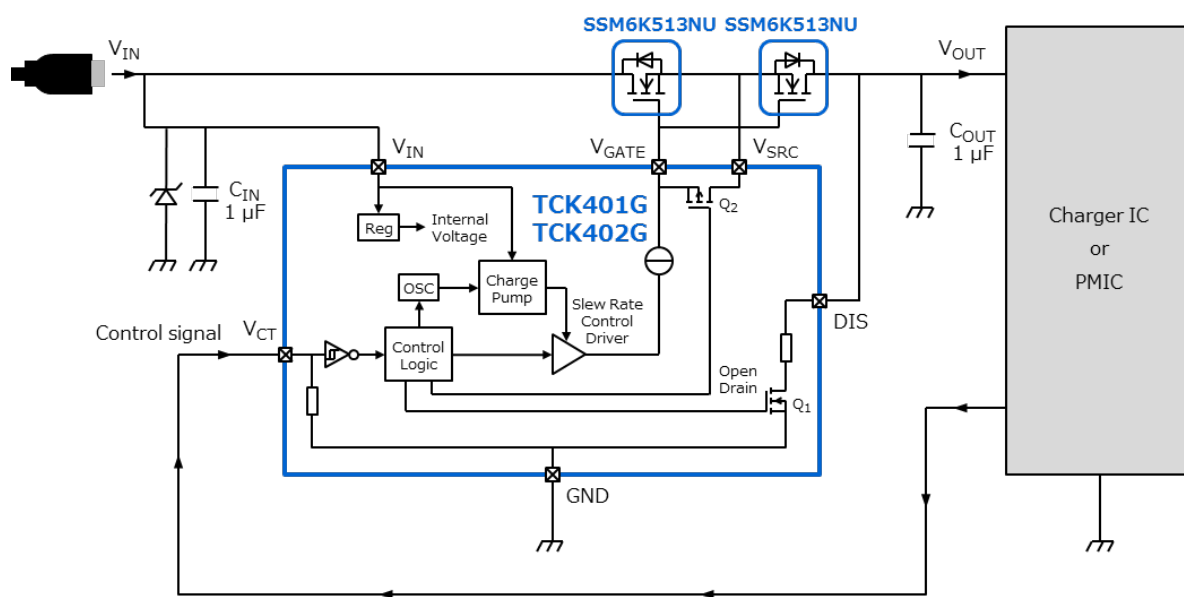


Figure 1.1 Application example for the TCK401G and TCK402G

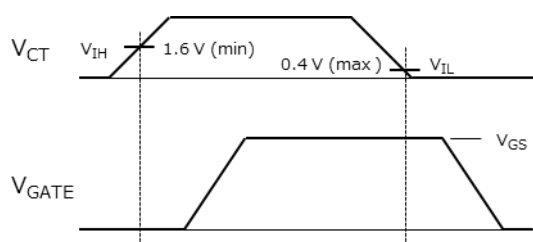
To perform a parametric search of MOSFETs suitable for applications like the one shown in Figure 1.1.

→ [Click Here](#)

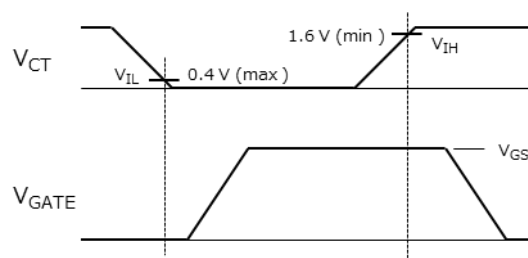
To perform a parametric search of TVS (ESD protection) diodes suitable for high-current applications such as charging circuits → [Click Here](#)

## 2. Difference between the TCK401G and TCK402G

The TCK401G and TCK402G differ only in the input logic of the mode control terminal ( $V_{CT}$ ) as shown in Table 2.1. Except for this difference in the input logic, they are identical in all other respects, including their operations and electrical characteristics. The TCK401G with the active-High  $V_{CT}$  terminal turns on when High-level voltage (i.e., voltage higher than  $V_{IH}$ ) is applied to the  $V_{CT}$  terminal as shown in Figure 2.1, causing the voltage of the  $V_{GATE}$  terminal, which drives external MOSFETs, to rise. In contrast, the TCK402G with the active-Low  $V_{CT}$  terminal turns on when Low-level voltage (i.e., voltage lower than  $V_{IL}$ ) is applied to the  $V_{CT}$  terminal as shown in Figure 2.2, causing the voltage of the  $V_{GATE}$  terminal to rise.



**Figure 2.1 Operation of the TCK401G (active-High)**

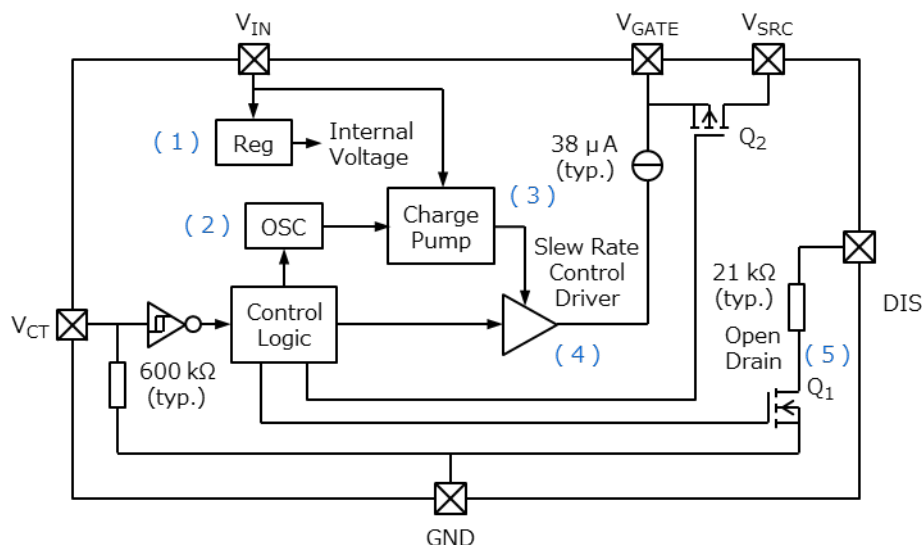


**Figure 2.2 Operation of the TCK402G (active-Low)**

**Table 2.1 Difference between the TCK401G and TCK402G**

Part number	Logical sense of $V_{CT}$	Pull resistor on $V_{CT}$
TCK401G	Active-High	Pull-down
TCK402G	Active-Low	Pull-down

### 3. Internal block diagram and operations of the TCK401G and TCK402G



**Figure 3.1 Internal block diagram of the TCK401G and TCK402G**

#### (1) Voltage regulator for the internal control circuit

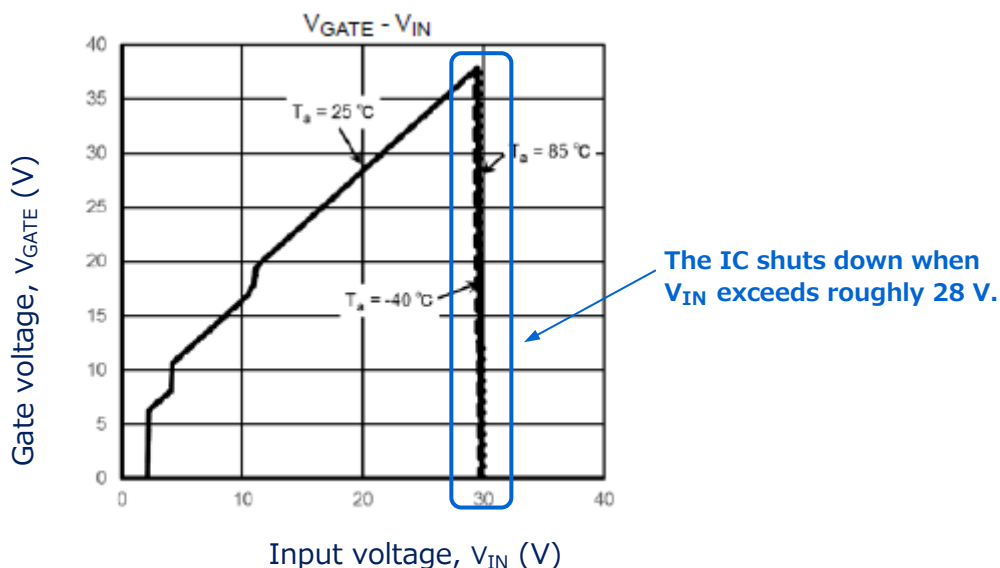
The voltage regulator regulates the supply voltage for the internal circuit.

#### (2) Oscillator

The oscillator drives a charge pump, which drives the gates of external N-channel MOSFETs.

#### (3) Charge pump

A charge pump is a voltage booster that generates a voltage for the gate drive of N-channel MOSFETs. In the case of the TCK401G and TCK402G, as the input voltage ( $V_{IN}$ ) increases, the gate voltage ( $V_{GATE}$ ) increases as shown in Figure 3.2. The charge pump controls voltage boost according to changes in the input voltage ( $V_{IN}$ ) so that the  $V_{GATE}$  voltage will not exceed the maximum permissible gate drive voltage ( $V_{GS}$ ). When  $V_{IN}$  exceeds roughly 28 V, the TCK401G and TCK402G shut down automatically for system protection. Table 3.1 shows the  $V_{GATE}$  characteristics with respect to  $V_{IN}$ . For example, when  $V_{IN} = 12$  V,  $V_{GATE}$  is 20.5 V typical ( $12$  V + 8.5 V) and 22 V maximum ( $12$  V + 10 V).



**Figure 3.2  $V_{GATE} - V_{IN}$  curve of the TCK401G and TCK402G**

**Table 3.1 Gate drive voltage characteristics of the TCK401G and TCK402G**

Characteristic	Symbol	Test Conditions	$T_a = 25^\circ\text{C}$			$T_a = -40 \text{ to } 85^\circ\text{C}$		Unit
			Min	Typ.	Max	Min	Max	
Gate drive voltage ( $V_{GATE} - V_{IN}$ )	$V_{GS}$	$V_{IN} = 3 \text{ V}$	–	4.0	–	2.8	5.1	V
		$V_{IN} = 5 \text{ V}$	–	6.5	–	5.1	7.9	V
		$V_{IN} = 9 \text{ V}$	–	6.5	–	5.1	7.9	V
		$12 \text{ V} \leq V_{IN} \leq 28 \text{ V}$	–	8.5	–	6.9	10	V

**(4) Gate drive circuit with inrush current suppression capability (slew rate control)**

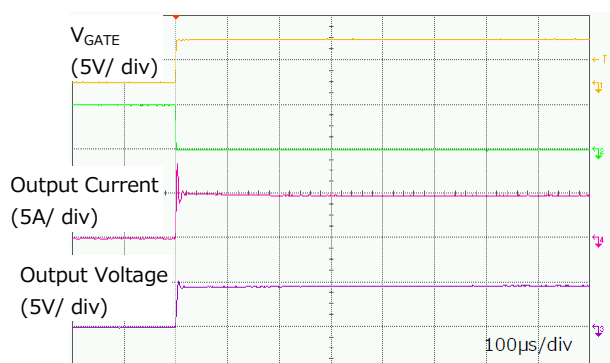
Inrush current is limited by the slew rate control circuit. When a large capacitive load is connected to the output MOSFET, turning it on at high speed causes a large current to flow to charge the load. At this time,  $V_{IN}$  drops instantaneously because of the impedance of board traces on the  $V_{DD}$  side of a load switch IC, causing system instability or malfunction. The slew rate control circuit limits inrush current to ensure a stable system boot-up. The TCK401 and TCK402G also incorporate a constant-current source (38  $\mu\text{A}$  typical), which drives the gates of external MOSFETs.

**Table 3.2 Output current (gate drive current) characteristic of the TCK401G and TCK402G**

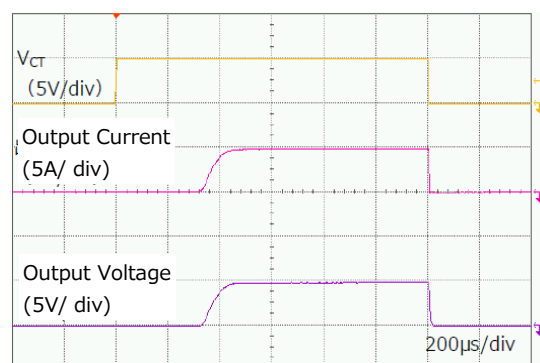
Characteristic	Symbol	Test Conditions	$T_a = 25^\circ\text{C}$			Unit
			Min	Typ.	Max	
Output current	$I_{GATE(ON)}$	$V_{IN} = 5 \text{ V}$	–	38	–	$\mu\text{A}$

Figure 3.3 shows the output waveforms of a load switch composed of discrete MOSFETs whereas Figure 3.4 shows the output waveforms of a load switch configured using the TCK401G.

Test conditions:  $V_{IN} = 5V$ ,  $V_{CT} = 0V \rightarrow 5V$ ,  $I_{OUT} = 5A$ ,  $C_{OUT} = 4.7\mu F$ ,  $T_a = 25^\circ C$



**Figure 3.3** Output waveforms of a load switch composed of discrete MOSFETs



**Figure 3.4** Output waveform of a load switch configured using the TCK401G

#### (4-1) When a load switch is composed of discrete MOSFETs (Figure 3.3)

In the case of a load switch composed of discrete MOSFETs, the peak output current of the MOSFETs with a  $C_{OUT}$  of  $4.7\mu F$  reaches 7 to 8 A when the load current is set to 5 A. In addition, the ringing caused by the peak current might generate electromagnetic interference (EMI) that adversely affects electronic circuits. It is therefore necessary to suppress inrush current during switch-on transitions.

#### (4-2) When the TCK401G is used (Figure 3.4)

In contrast, the TCK401G controls the rising slew rate of its output voltage to suppress inrush current, thereby reducing ringing and EMI. A downside of slew rate control is that it causes a delay from when a control signal is applied to the  $V_{CT}$  terminal of the TCK401G to when the TCK401G begins operation. This delay is caused by the time required for signal processing in the TCK401G.

\*  $V_{GATE}$  ON time ( $t_{ON}$ ) of the TCK401G

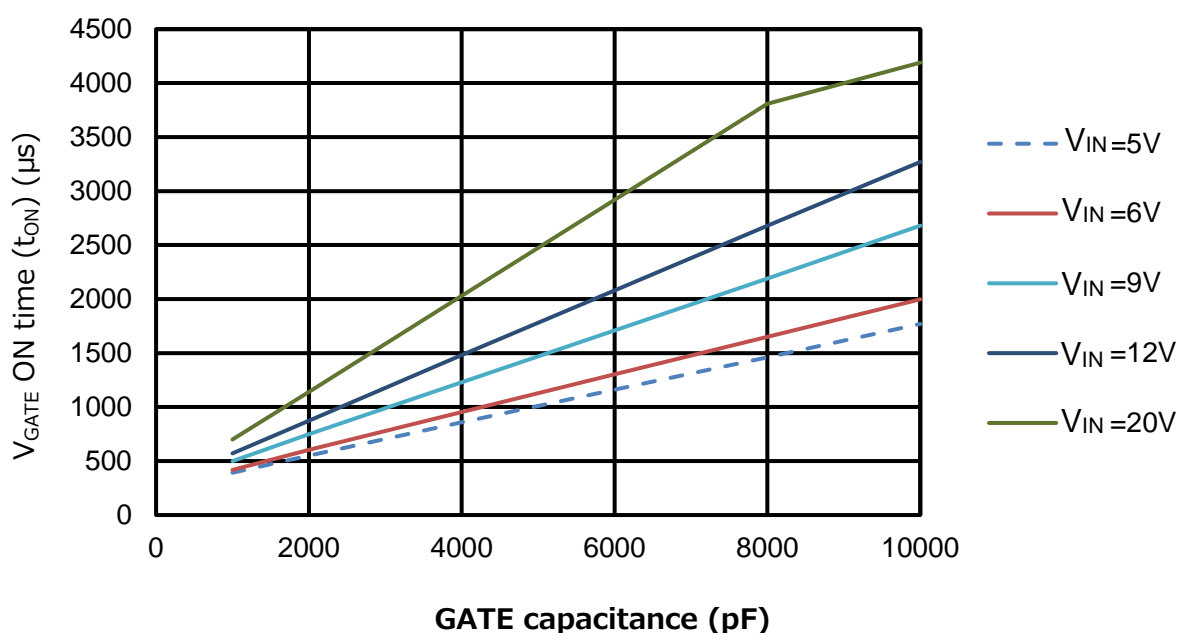
The  $V_{GATE}$  output of the TCK401G drives the MOSFET gate inputs. The  $V_{GATE}$  ON time ( $t_{ON}$ ) shown in its datasheet is not a specification that defines the switching time of external MOSFETs in actual applications. In practice, the turn-on time of the MOSFETs depends on their gate capacitance and threshold voltage ( $V_{th}$ ) as shown in Table 3.3 and Figure 3.5. The  $V_{GATE}$  ON time ( $t_{ON}$ ) of the TCK401G is specified at a gate capacitance of 2000 pF. The assumption is that the TCK401G is used to drive two back-to-back MOSFETs in a common-source configuration, each with a gate capacitance of roughly 1000 pF. When the TCK401G drives MOSFETs with lower gate capacitance, its  $V_{GATE}$  ON time is less than indicated in the datasheet. This means the switching time of external MOSFETs becomes shorter. Conversely, when the TCK401G drives MOSFETs with higher gate capacitance, the MOSFET switching time becomes longer because of a longer  $V_{GATE}$  ON time. When MOSFETs with a high threshold voltage ( $V_{th}$ ) are used, it is recommended to use the TCK401G at an input voltage ( $V_{IN}$ ) as high as possible in order to raise the  $V_{GATE}$  voltage. For a description of the datasheet specification



of the  $V_{GATE}$  ON time, see Section 5.1, "Switching times of the  $V_{GATE}$  terminal."

**Table 3.3  $V_{GATE}$  ON time ( $t_{ON}$ ) simulation data**

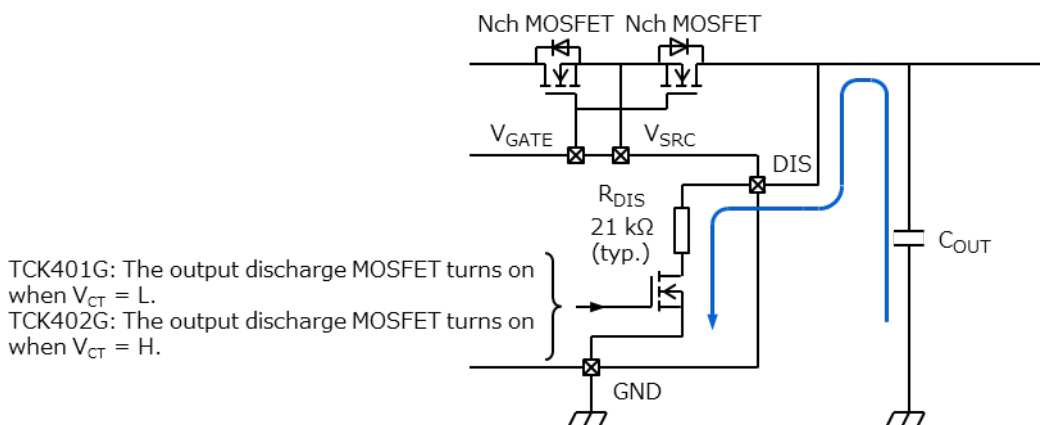
$V_{IN}$ (V)	Gate capacitance (pF)						Unit
	1000	2000	4000	6000	8000	10000	
$V_{IN} = 5$ V	392	550	860	1160	1460	1770	$\mu$ s
$V_{IN} = 6$ V	418	605	953	1302	1650	1998	
$V_{IN} = 9$ V	499	750	1230	1710	2190	2680	
$V_{IN} = 12$ V	571	874	1480	2080	2680	3270	
$V_{IN} = 20$ V	700	1140	2030	2920	3810	4190	



**Figure 3.5  $V_{GATE}$  ON time - Gate capacitance**

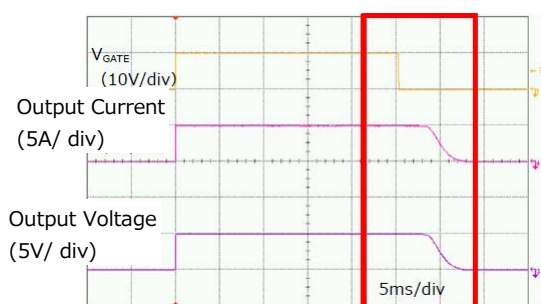
**(5) Automatic output discharge circuit**

A load remains charged after the TCK401G or TCK402G turns off when it is connected to a capacitive load. This makes it impossible to set an appropriate power supply sequence for a system with multiple load switch ICs. When a load switch IC turns off, the automatic output discharge circuit in the TCK401G or TCK402G turns on an internal MOSFET connected between DIS and GND terminals to discharge the load quickly. This circuit reduces the discharge time even when a large output capacitor is connected to a load switch IC, simplifying the setting of a system power sequence.

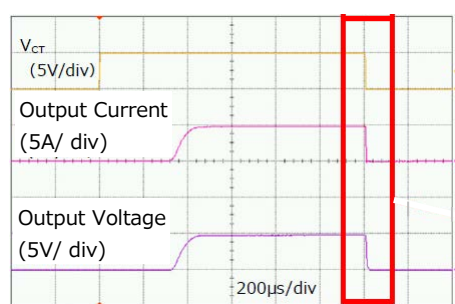


**Figure 3.6 Automatic output discharge circuit of the TCK401G and TCK402G**

Test conditions:  $V_{IN} = 5\text{ V}$ ,  $V_{CT} = 0\text{ V} \rightarrow 5\text{ V}$ ,  $I_{OUT} = 5\text{ A}$ ,  $C_{OUT} = 4.7\text{ }\mu\text{F}$ ,  $T_a = 25^\circ\text{C}$



**Figure 3.7 Output waveform of the TCK401G when the automatic output discharge function is disabled**

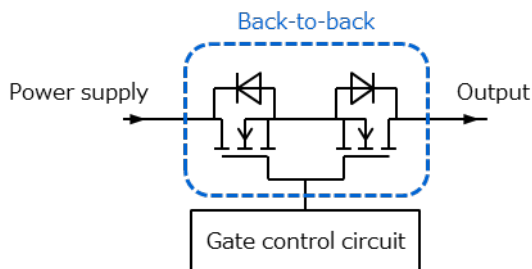


**Figure 3.8 Output waveform of the TCK401G when the automatic output discharge function is enabled**

## 4. Protection features

### 4.1. Reverse-current blocking using external common-source MOSFETs

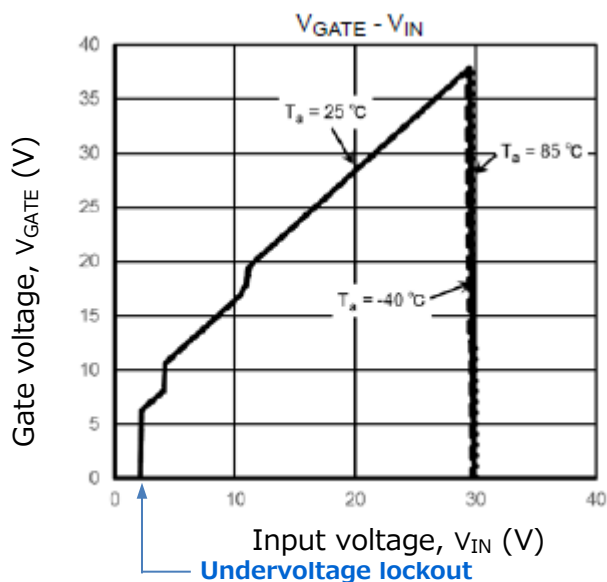
The reverse-current blocking function prevents current from flowing in the reverse direction from the output to the input when the TCK401G and TCK402G are disabled, for example, when the  $V_{IN}$  power supply is off or when the  $V_{CT}$  terminal is in the inactive state. The TCK401G and TCK402G provide reverse-current blocking using external back-to-back MOSFETs. When two external N-channel MOSFETs are connected back-to-back in a common-source configuration as shown in Figure 4.1, the TCK401G and TCK402G prevent reverse current at turn-off by switching off both the MOSFETs simultaneously.



**Figure 4.1 Reverse-current blocking using back-to-back MOSFETs**

## 4.2. Undervoltage lockout (UVLO)

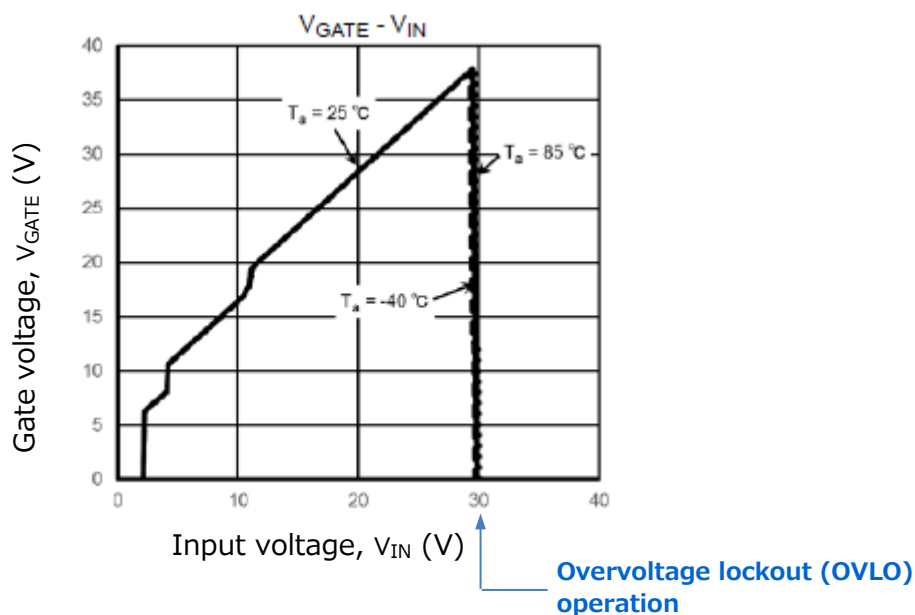
Undervoltage lockout (UVLO) is a feature to prevent system malfunction even when a decrease in  $V_{IN}$  causes the output gate voltage ( $V_{GATE}$ ) to drop below the minimum operating voltage of the subsequent IC or circuitry. The UVLO circuit turns off the output gate voltage ( $V_{GATE}$ ) in the event of an excessive drop in  $V_{IN}$ (Figure 4.2).



**Figure 4.2 Undervoltage lockout (UVLO) operation**

### 4.3. Overvoltage lockout (OVLO)

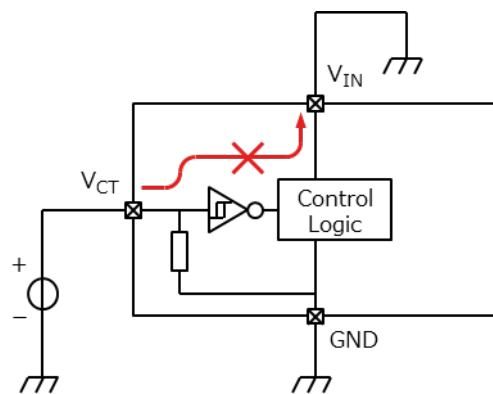
In the event of  $V_{IN}$  exceeding the prescribed voltage, the overvoltage lockout (OVLO) circuit turns off the output to protect the subsequent IC or circuitry(Figure 4.3).



**Figure 4.3 Overvoltage lockout (OVLO) operation**

### 4.4. Input-tolerant function

The input-tolerant function prevents current from flowing from the  $V_{CT}$  terminal to the  $V_{IN}$  terminal when the control terminal ( $V_{CT}$ ) voltage exceeds  $V_{IN}$  and when  $V_{IN} = 0$  V(Figure 4.4).



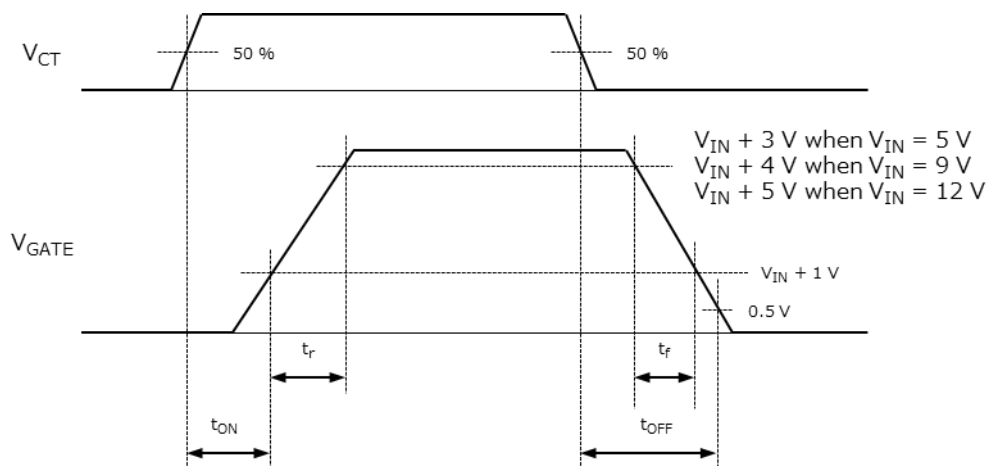
**Figure 4.4 Input-tolerant function**

## 5. Switching times of the TCK401G and TCK402G

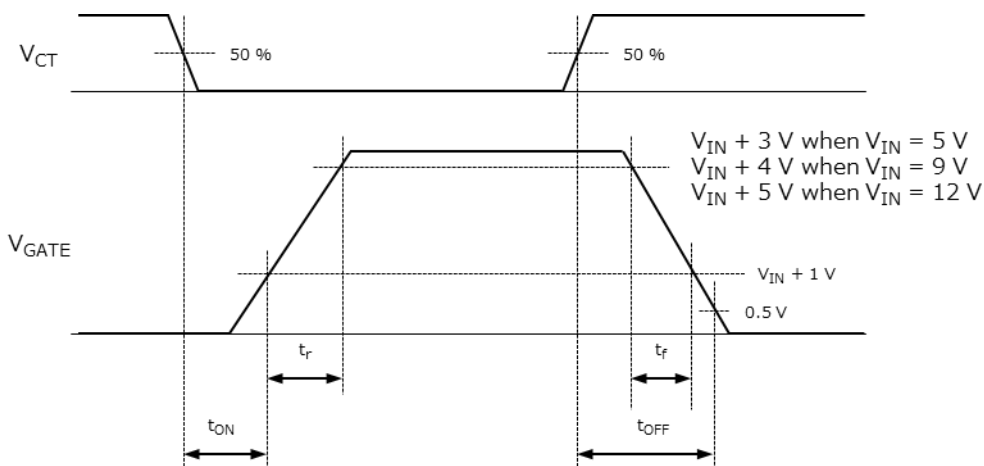
### 5.1. Switching times of the V<sub>GATE</sub> terminal

The V<sub>GATE</sub> output drives the gate inputs of external MOSFETs. When the V<sub>CT</sub> input assumes the active state, the TCK401G and TCK402G boost the voltage applied to the V<sub>IN</sub> input and pass it to the V<sub>GATE</sub> output. The following describes the conditions at which the slew rate control function is specified.

Figure 5.1 and Figure 5.2 show the timing chart of the V<sub>CT</sub> and V<sub>GATE</sub> terminals of the TCK401G and TCK402G respectively. The V<sub>GATE</sub> ON time (t<sub>ON</sub>) shown in the AC Characteristics table in the datasheet is the time required for the V<sub>GATE</sub> voltage to rise from the 50% point of V<sub>CT</sub> to (V<sub>IN</sub> + 1) V. The slew rate control circuit maintains the slope of the V<sub>GATE</sub> output. Therefore, the higher the V<sub>IN</sub> voltage, the longer the V<sub>GATE</sub> ON time (t<sub>ON</sub>). The V<sub>GATE</sub> OFF time (t<sub>OFF</sub>) is the time required for the V<sub>GATE</sub> voltage to decrease from the 50% point of V<sub>CT</sub> to 0.5 V.



**Figure 5.1 Switching times of the TCK401G**



**Figure 5.2 Switching times of the TCK402G**

## 6. Usage Considerations

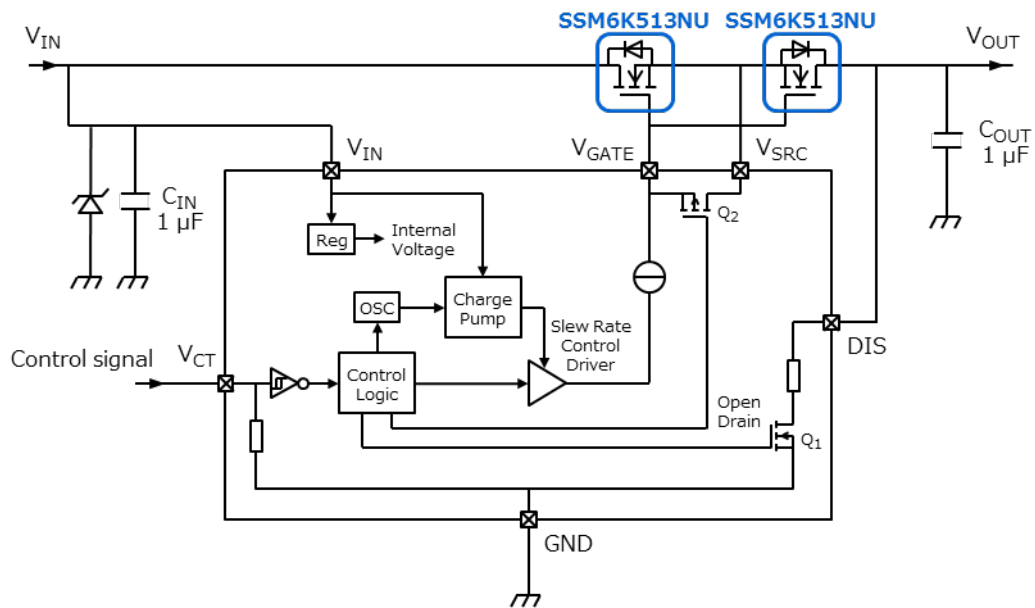


Figure 6.1 Applications circuit for the TCK401G and TCK402G

### 6.1. Input and output capacitors

Connect an input capacitor ( $C_{IN}$ ) and an output capacitor ( $C_{OUT}$ ) to ensure stable operation of the TCK401G and TCK402G.  $C_{IN}$  and  $C_{OUT}$  should be at least 1  $\mu\text{F}$  and connected as close as possible to the input and output terminals. The withstand voltage of these capacitors should be sufficiently higher than their operating voltage (Figure 6.1).

### 6.2. $V_{CT}$ terminal

A Schmitt trigger inverter is connected to the  $V_{CT}$  terminal of the TCK401G and TCK402G. The Schmitt trigger inverter has different thresholds ( $V_P$  and  $V_N$ ) for positive-going and negative-going inputs. As shown in Figure 6.2(b), it provides a stable output even in the event of the control signal being superimposed with contact chatter and ringing from a mechanical switch. In contrast, non-Schmitt inverters with a single threshold might cause the output to malfunction as shown in Figure 6.2 (a).

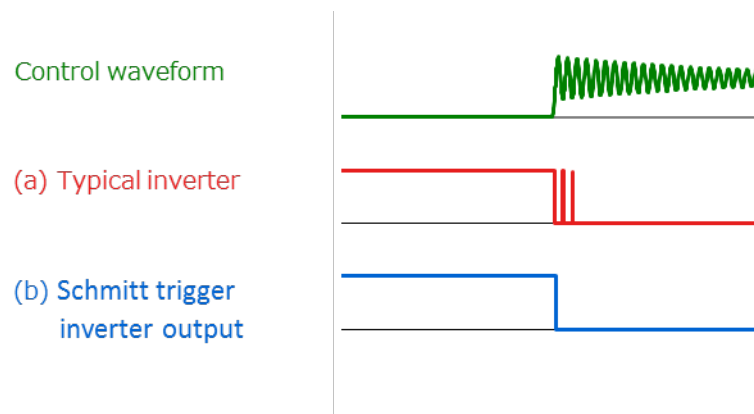


Figure 6.2 Operations of typical and Schmitt trigger inverters

### 6.3. $V_{SRC}$ terminal

When two MOSFETs are driven, voltage might remain at the  $V_{GATE}$  terminal even after the TCK401G or TCK402G switches off owing to the effect of capacitance, causing excessive gate-source voltage ( $V_{GS}$ ) to be applied to the MOSFETs. To prevent this, the  $V_{SRC}$  terminal short-circuits the  $V_{GATE}$  output to the source terminals of the MOSFETs when the TCK401G or TCK402G is off.

The  $V_{SRC}$  terminal may be left open if the MOSFETs have a sufficient margin for  $V_{GS}$ .

In cases where the TCK401G or TCK402G drives only one MOSFET, the  $V_{SRC}$  terminal may also be left open if the MOSFET gate-source voltage ( $V_{GS}$ ) has a sufficient margin.

It is recommended to connect  $V_{SRC}$  to  $V_{OUT}$  if  $V_{GS}$  does not have an adequate margin. Connecting the  $V_{SRC}$  and  $V_{OUT}$  terminals together causes an increase in  $t_{OFF}$  because of the effect of  $C_{OUT}$ .

Therefore, allow a sufficient margin when selecting MOSFETs.

### 6.4. DIS terminal

Connect the DIS terminal to  $V_{OUT}$  if automatic output discharge is necessary when the TCK401G or TCK402G turns off. Otherwise, the DIS terminal may be left open.

## 7. Conclusion

This application note has discussed the basics of the TCK401G and TCK402G, gate driver ICs for load switch ICs, such as their electrical characteristics and protection features shown in the datasheet. Load switch ICs are very effective for the power management of mobile and other electronic devices. Toshiba provides not only gate driver ICs but also various low-loss load switch ICs incorporating MOSFETs. We hope that you have found this application note useful in considering using load switch ICs.

## 8. Related Links

■ Product Line Ups (Catalog)

[Click](#)

■ Product Line Ups (Parametric search)

[Click](#)

■ Load Switch Line Ups (Parametric search)

[Click](#)

■ Stock check & Purchase



■ FAQ of Load Switch ICs

[Click](#)

■ Application Notes

[Click](#)



## 9. RESTRICTIONS ON PRODUCT USE

Toshiba Corporation and its subsidiaries and affiliates are collectively referred to as "TOSHIBA". Hardware, software and systems described in this document are collectively referred to as "Product".

- TOSHIBA reserves the right to make changes to the information in this document and related Product without notice.
- This document and any information herein may not be reproduced without prior written permission from TOSHIBA. Even with TOSHIBA's written permission, reproduction is permissible only if reproduction is without alteration/omission.
- Though TOSHIBA works continually to improve Product's quality and reliability, Product can malfunction or fail. Customers are responsible for complying with safety standards and for providing adequate designs and safeguards for their hardware, software and systems which minimize risk and avoid situations in which a malfunction or failure of Product could cause loss of human life, bodily injury or damage to property, including data loss or corruption. Before customers use the Product, create designs including the Product, or incorporate the Product into their own applications, customers must also refer to and comply with (a) the latest versions of all relevant TOSHIBA information, including without limitation, this document, the specifications, the data sheets and application notes for Product and the precautions and conditions set forth in the "TOSHIBA Semiconductor Reliability Handbook" and (b) the instructions for the application with which the Product will be used with or for. Customers are solely responsible for all aspects of their own product design or applications, including but not limited to (a) determining the appropriateness of the use of this Product in such design or applications; (b) evaluating and determining the applicability of any information contained in this document, or in charts, diagrams, programs, algorithms, sample application circuits, or any other referenced documents; and (c) validating all operating parameters for such designs and applications. **TOSHIBA ASSUMES NO LIABILITY FOR CUSTOMERS' PRODUCT DESIGN OR APPLICATIONS.**
- **PRODUCT IS NEITHER INTENDED NOR WARRANTED FOR USE IN EQUIPMENTS OR SYSTEMS THAT REQUIRE EXTRAORDINARILY HIGH LEVELS OF QUALITY AND/OR RELIABILITY, AND/OR A MALFUNCTION OR FAILURE OF WHICH MAY CAUSE LOSS OF HUMAN LIFE, BODILY INJURY, SERIOUS PROPERTY DAMAGE AND/OR SERIOUS PUBLIC IMPACT ("UNINTENDED USE").** Except for specific applications as expressly stated in this document, Unintended Use includes, without limitation, equipment used in nuclear facilities, equipment used in the aerospace industry, lifesaving and/or life supporting medical equipment, equipment used for automobiles, trains, ships and other transportation, traffic signaling equipment, equipment used to control combustions or explosions, safety devices, elevators and escalators, and devices related to power plant. **IF YOU USE PRODUCT FOR UNINTENDED USE, TOSHIBA ASSUMES NO LIABILITY FOR PRODUCT.** For details, please contact your TOSHIBA sales representative or contact us via our website.
- Do not disassemble, analyze, reverse-engineer, alter, modify, translate or copy Product, whether in whole or in part.
- Product shall not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable laws or regulations.
- The information contained herein is presented only as guidance for Product use. No responsibility is assumed by TOSHIBA for any infringement of patents or any other intellectual property rights of third parties that may result from the use of Product. No license to any intellectual property right is granted by this document, whether express or implied, by estoppel or otherwise.
- **ABSENT A WRITTEN SIGNED AGREEMENT, EXCEPT AS PROVIDED IN THE RELEVANT TERMS AND CONDITIONS OF SALE FOR PRODUCT, AND TO THE MAXIMUM EXTENT ALLOWABLE BY LAW, TOSHIBA (1) ASSUMES NO LIABILITY WHATSOEVER, INCLUDING WITHOUT LIMITATION, INDIRECT, CONSEQUENTIAL, SPECIAL, OR INCIDENTAL DAMAGES OR LOSS, INCLUDING WITHOUT LIMITATION, LOSS OF PROFITS, LOSS OF OPPORTUNITIES, BUSINESS INTERRUPTION AND LOSS OF DATA, AND (2) DISCLAIMS ANY AND ALL EXPRESS OR IMPLIED WARRANTIES AND CONDITIONS RELATED TO SALE, USE OF PRODUCT, OR INFORMATION, INCLUDING WARRANTIES OR CONDITIONS OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, ACCURACY OF INFORMATION, OR NONINFRINGEMENT.**
- Do not use or otherwise make available Product or related software or technology for any military purposes, including without limitation, for the design, development, use, stockpiling or manufacturing of nuclear, chemical, or biological weapons or missile technology products (mass destruction weapons). Product and related software and technology may be controlled under the applicable export laws and regulations including, without limitation, the Japanese Foreign Exchange and Foreign Trade Law and the U.S. Export Administration Regulations. Export and re-export of Product or related software or technology are strictly prohibited except in compliance with all applicable export laws and regulations.
- Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product. Please use Product in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. **TOSHIBA ASSUMES NO LIABILITY FOR DAMAGES OR LOSSES OCCURRING AS A RESULT OF NONCOMPLIANCE WITH APPLICABLE LAWS AND REGULATIONS.**